

Keysight U1700 Series Handheld LCR Meters

Data Sheet



Test passive components conveniently, affordably *and* reliably with the Keysight U1700 Series LCR meters—extending the tradition of industry-leading benchtop units

Introduction

The Keysight Technologies, Inc. U1700 Series handheld LCR meters expand Keysight's portfolio of handheld tools into electronics assembly and passive components troubleshooting. Better yet, these handheld models extends the tradition of Keysight's industry-leading benchtop units to more affordable and portable forms. Keysight's latest handheld LCR meters in all-new orange offer capabilities and functionalities equivalent to the A models.

No waiting for quick, basic LCR tests

Sharing a bench LCR meter is practical, but isn't always convenient. With Keysight's new line of handheld LCR meters, you can perform quick, basic LCR measurements at your convenience. Now that they're available at a lower price point compared to traditional benchtop units, everyone on your team can be equipped for passive-component testing—on the bench or on the go—without the wait.

Uncompromised quality and reliability

The handheld LCR meters are housed in robust overmold and tested to stringent industrial standards.

Features

- 20,000 counts resolution
- Dual display with backlight (for U1732A/U1732B)
- Wide LCR ranges with 2 to 4 selectable test frequencies
- Auto-calculation of phase angle (for U1732A/U1732B), dissipation factor and quality factor
- Tolerance mode: 1%, 5% and 10% (20% with U1732A/U1732B)
- Relative mode
- Hold and Min/Max/Average recordings
- Data logging to PC with optional IR-to-USB cable



Figure 1: Automate the recording of continuous readings when you hook the U1731A/U1731B/U1732A/U1732B to a PC

Take a closer look



Figure 2: U1732B front view

U1731A/U1731B Electrical Specifications

Accuracy is expressed as \pm (% of reading + number of least significant digits) at 23 °C \pm 5 °C and <75% R.H.

Resistance (Parallel Mode), Test Frequency = 120 Hz/1 kHz

| Range | Maximum Display | Accuracy | | Note |
|-----------------|-------------------|-----------|-----------|------------------|
| | | @ 120 Hz | @ 1 kHz | |
| 10 M Ω | 9.999 M Ω | 2.0% + 8 | 2.0% + 8 | After open cal. |
| 2000 k Ω | 1999.9 k Ω | 0.5% + 5 | 0.5% + 5 | After open cal. |
| 200 k Ω | 199.99 k Ω | 0.5% + 3 | 0.5% + 3 | - |
| 20 k Ω | 19.999 k Ω | 0.5% + 3 | 0.5% + 3 | - |
| 2000 Ω | 1999.9 Ω | 0.5% + 3 | 0.5% + 3 | - |
| 200 Ω | 199.99 Ω | 0.8% + 5 | 0.8% + 5 | After short cal. |
| 20 Ω | 19.999 Ω | 1.2% + 40 | 1.2% + 40 | After short cal. |

1. Specifications are based on measurements performed at the test sockets and on battery operation.
2. DUT and test leads need to be properly shielded by connecting to the guard terminal, if necessary.

Capacitance (Parallel Mode), Test Frequency = 120 Hz

| Range | Maximum Display | Accuracy | | Note |
|---------|------------------------|-------------------|----------------------------|------------------|
| | | Capacitance | DF | |
| 10 mF | 19.99 mF ¹ | 3.0% + 5 (DF<0.1) | 10% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 1000 µF | 1999.9 µF ² | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 200 µF | 199.99 µF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 20 µF | 19.999 µF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 2000 nF | 1999.9 nF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 200 nF | 199.99 nF | 0.7% + 5 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | After open cal. |
| 20 nF | 19.999 nF | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After open cal. |

Capacitance (Parallel Mode), Test Frequency = 1 kHz

| Range | Maximum Display | Accuracy | | Note |
|---------|-----------------------|-------------------|----------------------------|------------------|
| | | Capacitance | DF | |
| 1 mF | 1.999 mF ¹ | 3.0% + 5 (DF<0.1) | 10% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 200 µF | 199.99 µF | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 20 µF | 19.999 µF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 2000 nF | 1999.9 nF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 200 nF | 199.99 nF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 20 nF | 19.999 nF | 0.7% + 5 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | After open cal. |
| 2000 pF | 1999.9 pF | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After open cal. |

1. This reading can be extended up to 1999 MAX display with accuracy that is not specified.
2. This reading can be extended up to 19999 MAX display with accuracy that is not specified.
3. Q value is the reciprocal of DF.
4. Cx = Counts of displayed C value. E.g., If C = 88.88 µF then Cx = 8888.
5. Specifications are based on measurements performed at the test sockets and on battery operation.
6. DUT and test leads need to be properly shielded by connecting to the guard terminal, if necessary.

Inductance (Series Mode), Test Frequency = 120 Hz

| Range | Maximum Display | Accuracy | | Note |
|---------|-----------------|-----------------------------|------------------------|------------------|
| | | Inductance | DF | |
| 1000 H | 999.9 H | $1.0\% + (L_x/10000)\% + 5$ | $2.0\% + 100/L_x + 5$ | After open cal. |
| 200 H | 199.99 H | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 20 H | 19.999 H | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 2000 mH | 1999.9 mH | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 200 mH | 199.99 mH | $1.0\% + (L_x/10000)\% + 5$ | $3.0\% + 100/L_x + 5$ | After short cal. |
| 20 mH | 19.999 mH | $2.0\% + (L_x/10000)\% + 5$ | $10.0\% + 100/L_x + 5$ | After short cal. |

Inductance (Series Mode), Test Frequency = 1 kHz

| Range | Maximum Display | Accuracy | | Note |
|--------------|-----------------|-----------------------------|------------------------|------------------|
| | | Inductance | DF | |
| 100 H | 99.99 H | $1.0\% + (L_x/10000)\% + 5$ | $2.0\% + 100/L_x + 5$ | After open cal. |
| 20 H | 19.999 H | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 2000 mH | 1999.9 mH | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 200 mH | 199.99 mH | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 20 mH | 19.999 mH | $1.0\% + (L_x/10000)\% + 5$ | $3.0\% + 100/L_x + 5$ | After short cal. |
| 2000 μ H | 1999.9 μ H | $2.0\% + (L_x/10000)\% + 5$ | $10.0\% + 100/L_x + 5$ | After short cal. |

1. Q value is the reciprocal of DF.
2. L_x = Counts of displayed L value. E.g., If $L = 88.88$ H then $L_x = 8888$.
3. Specifications are based on measurements performed at the test sockets and on battery operation.
4. DUT and test leads need to be properly shielded by connecting to the guard terminal, if necessary.

U1732A/U1732B Electrical Specifications

Accuracy is expressed as \pm (% of reading + number of least significant digits) at $23\text{ }^{\circ}\text{C} \pm 5\text{ }^{\circ}\text{C}$ and $<75\%$ R.H.

Resistance (Parallel Mode), Test Frequency = 100 Hz/120 Hz

| Range | Maximum Display | Accuracy | | Note |
|-----------------|-------------------|-----------|-----------|------------------|
| | | @ 100 Hz | @ 120 Hz | |
| 10 M Ω | 9.999 M Ω | 2.0% + 8 | 2.0% + 8 | After open cal. |
| 2000 k Ω | 1999.9 k Ω | 0.5% + 5 | 0.5% + 5 | After open cal. |
| 200 k Ω | 199.99 k Ω | 0.5% + 3 | 0.5% + 3 | - |
| 20 k Ω | 19.999 k Ω | 0.5% + 3 | 0.5% + 3 | - |
| 2000 Ω | 1999.9 Ω | 0.5% + 3 | 0.5% + 3 | - |
| 200 Ω | 199.99 Ω | 0.8% + 5 | 0.8% + 5 | After short cal. |
| 20 Ω | 19.999 Ω | 1.2% + 40 | 1.2% + 40 | After short cal. |

Resistance (Parallel Mode), Test Frequency = 1 kHz/10 kHz

| Range | Maximum Display | Accuracy | | Note |
|-----------------|-------------------|-----------|------------|------------------|
| | | @ 1 kHz | @ 10 kHz | |
| 10 M Ω | 9.999 M Ω | 2.0% + 8 | 3.5% + 10 | After open cal. |
| 2000 k Ω | 1999.9 k Ω | 0.5% + 5 | 2.0% + 10 | After open cal. |
| 200 k Ω | 199.99 k Ω | 0.5% + 3 | 1.5% + 5 | - |
| 20 k Ω | 19.999 k Ω | 0.5% + 3 | 1.5% + 5 | - |
| 2000 Ω | 1999.9 Ω | 0.5% + 3 | 1.5% + 5 | - |
| 200 Ω | 199.99 Ω | 0.8% + 5 | 2.0% + 10 | After short cal. |
| 20 Ω | 19.999 Ω | 1.2% + 40 | 2.5% + 200 | After short cal. |

1. Specifications are based on measurements performed at the test sockets and on battery operation.
2. DUT and test leads need to be properly shielded by connecting to the guard terminal, if necessary.

Capacitance (Parallel Mode), Test Frequency = 100 Hz/120 Hz

| Range | Maximum Display | Accuracy | | Note |
|---------|-----------------|-------------------|----------------------------|------------------|
| | | Capacitance | DF | |
| 10 mF | 19.99 mF [1] | 3.0% + 5 (DF<0.1) | 10% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 1000 µF | 1999.9 µF [2] | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 200 µF | 199.99 µF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 20 µF | 19.999 µF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 2000 nF | 1999.9 nF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 200 nF | 199.99 nF | 0.7% + 5 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | After open cal. |
| 20 nF | 19.999 nF | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After open cal. |

Capacitance (Parallel Mode), Test Frequency = 1 kHz

| Range | Maximum Display | Accuracy | | Note |
|---------|-----------------|-------------------|----------------------------|------------------|
| | | Capacitance | DF | |
| 1 mF | 1.999 mF [1] | 3.0% + 5 (DF<0.1) | 10% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 200 µF | 199.99 µF | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After short cal. |
| 20 µF | 19.999 µF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 2000 nF | 1999.9 nF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 200 nF | 199.99 nF | 0.7% + 3 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | - |
| 20 nF | 19.999 nF | 0.7% + 5 (DF<0.5) | 0.7% + 100/Cx + 5 (DF<0.5) | After open cal. |
| 2000 pF | 1999.9 pF | 1.0% + 5 (DF<0.1) | 2.0% + 100/Cx + 5 (DF<0.1) | After open cal. |

Capacitance (Parallel Mode), Test Frequency = 10 kHz

| Range | Maximum Display | Accuracy | | Note |
|---------|-----------------|-------------------|------------------------------|------------------|
| | | Capacitance | DF | |
| 50 µF | 50.0 µF | 3.0% + 8 (DF<0.1) | 12.0% + 100/Cx + 10 (DF<0.1) | After short cal. |
| 20 µF | 19.999 µF | 3.0% + 6 (DF<0.2) | 5.0% + 100/Cx + 8 (DF<0.2) | After short cal. |
| 2000 nF | 1999.9 nF | 1.5% + 5 (DF<0.5) | 1.5% + 100/Cx + 6 (DF<0.5) | - |
| 200 nF | 199.99 nF | 1.5% + 5 (DF<0.5) | 1.5% + 100/Cx + 6 (DF<0.5) | - |
| 20 nF | 19.999 nF | 1.5% + 5 (DF<0.5) | 1.5% + 100/Cx + 6 (DF<0.5) | - |
| 2000 pF | 1999.9 pF | 2.0% + 6 (DF<0.5) | 3.0% + 100/Cx + 6 (DF<0.1) | After open cal. |
| 200pF | 199.99 pF | 3.0% + 8 (DF<0.1) | 5.0% + 100/Cx + 8 (DF<0.1) | After open cal. |

1. This reading can be extended up to 1999 MAX display with accuracy that is not specified.
2. This reading can be extended up to 19999 MAX display with accuracy that is not specified.
3. Q value is the reciprocal of DF.
4. Cx = Counts of displayed C value. E.g., If C = 88.88 µF then Cx = 8888.
5. Specifications are based on measurements performed at the test sockets and on battery operation.
6. DUT and test leads need to be properly shielded by connecting to the guard terminal, if necessary.

Inductance (Series Mode), Test Frequency = 100 Hz/120 Hz

| Range | Maximum Display | Accuracy | | Note |
|---------|-----------------|-----------------------------|------------------------|------------------|
| | | Inductance | DF | |
| 1000 H | 999.9 H | $1.0\% + (L_x/10000)\% + 5$ | $2.0\% + 100/L_x + 5$ | After open cal. |
| 200 H | 199.99 H | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 20 H | 19.999 H | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 2000 mH | 1999.9 mH | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 200 mH | 199.99 mH | $1.0\% + (L_x/10000)\% + 5$ | $3.0\% + 100/L_x + 5$ | After short cal. |
| 20 mH | 19.999 mH | $2.0\% + (L_x/10000)\% + 5$ | $10.0\% + 100/L_x + 5$ | After short cal. |

Inductance (Series Mode), Test Frequency = 1 kHz


| Range | Maximum Display | Accuracy | | Note |
|--------------|-----------------|-----------------------------|------------------------|------------------|
| | | Inductance | DF | |
| 100 H | 99.99 H | $1.0\% + (L_x/10000)\% + 5$ | $2.0\% + 100/L_x + 5$ | After open cal. |
| 20 H | 19.999 H | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 2000 mH | 1999.9 mH | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 200 mH | 199.99 mH | $0.7\% + (L_x/10000)\% + 5$ | $1.2\% + 100/L_x + 5$ | - |
| 20 mH | 19.999 mH | $1.0\% + (L_x/10000)\% + 5$ | $3.0\% + 100/L_x + 5$ | After short cal. |
| 2000 μ H | 1999.9 μ H | $2.0\% + (L_x/10000)\% + 5$ | $10.0\% + 100/L_x + 5$ | After short cal. |

Inductance (Series Mode), Test Frequency = 10 kHz

| Range | Maximum Display | Accuracy | | Note |
|--------------|-----------------|------------------------------|------------------------|------------------|
| | | Inductance | DF | |
| 1000 mH | 999.9 mH | $2.0\% + (L_x/10000)\% + 8$ | $2.0\% + 100/L_x + 10$ | - |
| 200 mH | 199.99 mH | $1.5\% + (L_x/10000)\% + 8$ | $2.0\% + 100/L_x + 10$ | - |
| 20 mH | 19.999 mH | $1.5\% + (L_x/10000)\% + 10$ | $3.0\% + 100/L_x + 15$ | After short cal. |
| 2000 μ H | 1999.9 μ H | $2.0\% + (L_x/10000)\% + 10$ | $8.0\% + 100/L_x + 20$ | |

1. Q value is the reciprocal of DF.
2. L_x = counts of displayed L value. E.g., If $L = 88.88$ H, then $L_x = 8888$.
3. Specifications are based on measurements performed at the test sockets and on battery operation.
4. DUT and test leads need to be properly shielded by connecting to the guard terminal, if necessary.

General Specifications

| Parameter | U1731A/U1731B | | U1732A/U1732B | |
|--|---|-----------------------|-------------------------------------|--|
| Measurements | L/C/R/D/Q | | L/C/R/D/Q/q | |
| Tolerance mode | 1%, 5%, 10% | | 1%, 5%, 10%, 20% | |
| Test frequency (Accuracy = $\pm 0.1\%$ of actual test frequency) | Test frequency setting | Actual test frequency | Test frequency setting | Actual test frequency |
| | 120 Hz 1 kHz | 120 Hz 1010 Hz | 100 Hz 120 Hz 1 kHz 10 kHz | 100 Hz 120 Hz 1010 Hz 9.6 kHz |
| Measuring circuit mode | Inductance (L): Defaults to series mode Capacitance/Resistance (C/R): Defaults to parallel mode | | | |
| Display | L/C/R : Maximum display 19999 D/Q: Maximum display 999 (Auto range) | | | |
| Backlight | Available for model U1732A/U1732B | | | |
| Ranging mode | Auto and Manual | | | |
| Test signal level | $\sim 0.6 V_{RMS}$ | | | |
| Measurement rate | 1 reading/s, nominal | | | |
| Response time | ~ 1 s/DUT (manual range) | | | |
| Auto power-off | ~ 5 mins without operation | | | |
| Power supply | <ul style="list-style-type: none"> 9 V Alkaline battery (ANSI/NEDA 1604A or IEC 6LR61) AC power adapter and cord available as options | | | |
| Power consumption | <ul style="list-style-type: none"> ~ 40 mA (on battery operation) 0.08 mA after auto power-off | | | |
| Input protection fuse | 0.1 A/250 V | | | |
| Battery life | 7 hours (typical) without backlight and based on new alkaline | | | |
| Low battery indicator |  will appear when the voltage drops below ~ 6.8 V | | | |
| Operating environment | 0 °C to 40 °C; 0 to 70% relative humidity (R.H.) | | | |
| Storage environment | -20 °C to 50 °C; 0 to 80% R.H. non-condensing | | | |
| Temperature coefficient | 0.15 x (specified accuracy)/°C (0 °C to 18 °C or 28 °C to 40 °C) | | | |
| Weight | 330 g | | | |
| Dimensions (H x W x D) | 184 mm x 87 mm x 41 mm | | | |
| Safety and EMC compliance | IEC 61010-1:2001/EN 61010-1:2001 (2 nd Edition) Pollution Degree 2, IEC 61326-2-1:2005/EN 61326-2-1:2006, ICES-001:2004, AS/NZS CISPR11:2004 | | | |
| Calibration | One-year calibration cycle recommended | | | |

Ordering Information



U1731A

U1732A

U1732B

U1731B

Standard shipped items

Standard U1731A, U1731B, U1732A and U1732B ordering include:

- Quick Start Guide
- Certificate of Calibration (CoC)
- Alligator clip leads
- 9 V Alkaline battery

Option U1731A-SMD and U1732A-SMD ordering includes (For A series handheld LCR meters only) :
SMD tweezer and soft carrying case in addition to the standard shipped items

Recommended accessories



U1174A Soft carrying case



U5481A IR-to-USB cable



U1782A SMD tweezer



U1780A Power adapter and cord (according to country)

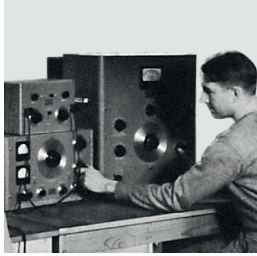


U1781A Alligator clip leads

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